

**Search Notes**

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TAN X. DINH

Applicant(s)/Patent under  
Reexamination

AIKOH ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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Interference Search History Printout		7/3/2006	T.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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